

# SSM3J168F

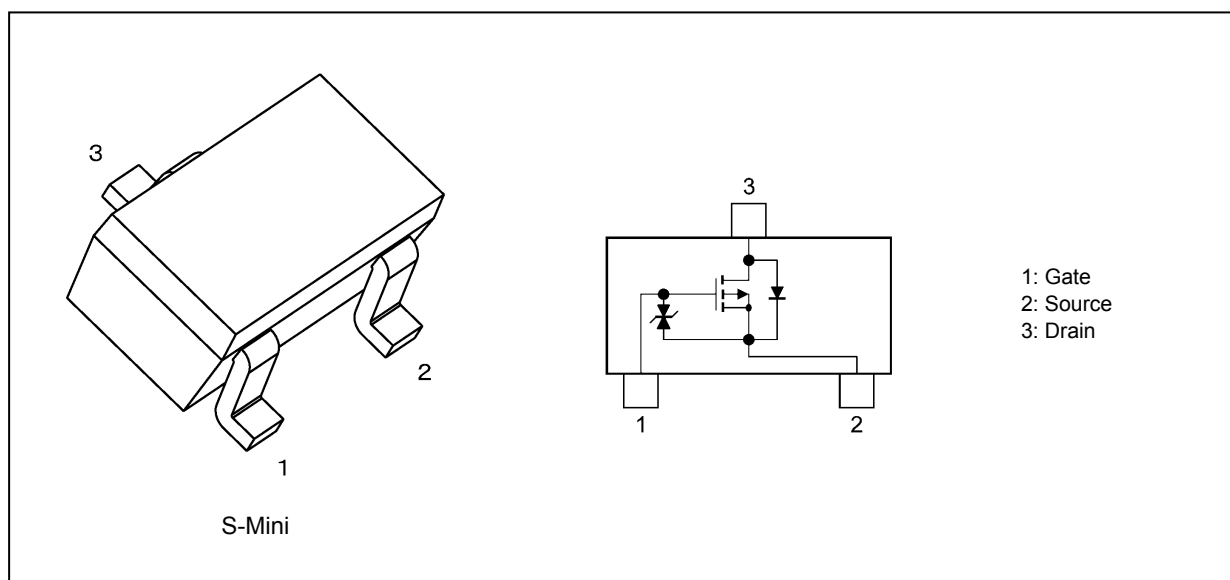
## 1. Applications

- High-Speed Switching
- Analog Switches
- Interfacing

## 2. Features

- (1) 4.0 V drive
- (2) Low drain-source on-resistance
  - :  $R_{DS(ON)} = 1.6 \Omega$  (typ.) ( $V_{GS} = -4.0 \text{ V}$ )
  - $R_{DS(ON)} = 1.4 \Omega$  (typ.) ( $V_{GS} = -4.5 \text{ V}$ )
  - $R_{DS(ON)} = 1.3 \Omega$  (typ.) ( $V_{GS} = -10 \text{ V}$ )

## 3. Packaging and Pin Assignment



Start of commercial production

2016-11

#### 4. Absolute Maximum Ratings (Note) (Unless otherwise specified, $T_a = 25\text{ }^{\circ}\text{C}$ )

| Characteristics                                | Symbol    | Rating     | Unit               |
|------------------------------------------------|-----------|------------|--------------------|
| Drain-source voltage                           | $V_{DS}$  | -60        | V                  |
| Gate-source voltage                            | $V_{GS}$  | -20/+10    |                    |
| Drain current (DC) (Note 1)                    | $I_D$     | -400       | mA                 |
| Drain current (pulsed) (Note 1)                | $I_{DP}$  | -800       |                    |
| Power dissipation (Note 2)                     | $P_D$     | 600        | mW                 |
| Power dissipation $t \leq 1\text{ s}$ (Note 2) |           | 1200       |                    |
| Channel temperature                            | $T_{ch}$  | 150        | $^{\circ}\text{C}$ |
| Storage temperature                            | $T_{stg}$ | -55 to 150 |                    |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Note 1: Ensure that the channel temperature does not exceed  $150\text{ }^{\circ}\text{C}$ .

Note 2: Device mounted on a  $25.4\text{ mm} \times 25.4\text{ mm} \times 1.6\text{ mm}$  FR4 glass epoxy board (Cu pad:  $645\text{ mm}^2$ )

Note: This transistor is sensitive to electrostatic discharge and should be handled with care.

Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.

Note: The channel-to-ambient thermal resistance,  $R_{th(ch-a)}$ , and the drain power dissipation,  $P_D$ , vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.

## 5. Electrical Characteristics

### 5.1. Static Characteristics (Unless otherwise specified, $T_a = 25\text{ }^{\circ}\text{C}$ )

| Characteristics                         | Symbol        | Test Condition                                               | Min  | Typ. | Max      | Unit          |
|-----------------------------------------|---------------|--------------------------------------------------------------|------|------|----------|---------------|
| Gate leakage current                    | $I_{GSS}$     | $V_{DS} = 0\text{ V}$ , $V_{GS} = -16\text{ V}/+10\text{ V}$ | —    | —    | $\pm 10$ | $\mu\text{A}$ |
| Drain cut-off current                   | $I_{DSS}$     | $V_{DS} = -60\text{ V}$ , $V_{GS} = 0\text{ V}$              | —    | —    | -10      |               |
| Drain-source breakdown voltage          | $V_{(BR)DSS}$ | $I_D = -1\text{ mA}$ , $V_{GS} = 0\text{ V}$                 | -60  | —    | —        | V             |
| Drain-source breakdown voltage (Note 1) | $V_{(BR)DSX}$ | $I_D = -1\text{ mA}$ , $V_{GS} = 10\text{ V}$                | -50  | —    | —        |               |
| Gate threshold voltage (Note 2)         | $V_{th}$      | $V_{DS} = -10\text{ V}$ , $I_D = -1\text{ mA}$               | -0.8 | —    | -2.0     |               |
| Drain-source on-resistance (Note 3)     | $R_{DS(ON)}$  | $I_D = -100\text{ mA}$ , $V_{GS} = -4.0\text{ V}$            | —    | 1.6  | 2.0      | $\Omega$      |
|                                         |               | $I_D = -100\text{ mA}$ , $V_{GS} = -4.5\text{ V}$            | —    | 1.4  | 1.9      |               |
|                                         |               | $I_D = -200\text{ mA}$ , $V_{GS} = -10\text{ V}$             | —    | 1.3  | 1.55     |               |

Note 1: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.

Note 2: Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current ( $I_D$ ) to below (-1 mA for this device). Then, for normal switching operation,  $V_{GS(ON)}$  must be higher than  $V_{th}$ , and  $V_{GS(OFF)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ .

Take this into consideration when using the device.

Note 3: Pulse measurement.

### 5.2. Dynamic Characteristics (Unless otherwise specified, $T_a = 25\text{ }^{\circ}\text{C}$ )

| Characteristics                | Symbol    | Test Condition                                                                                                                                                                                                          | Min | Typ. | Max | Unit |
|--------------------------------|-----------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|------|-----|------|
| Input capacitance              | $C_{iss}$ | $V_{DS} = -10\text{ V}$ , $V_{GS} = 0\text{ V}$ ,<br>$f = 1\text{ MHz}$                                                                                                                                                 | —   | 82   | —   | pF   |
| Reverse transfer capacitance   | $C_{rss}$ |                                                                                                                                                                                                                         | —   | 5.5  | —   |      |
| Output capacitance             | $C_{oss}$ |                                                                                                                                                                                                                         | —   | 13   | —   |      |
| Switching time (turn-on time)  | $t_{on}$  | $V_{DD} = -30\text{ V}$ , $I_D = -0.1\text{ A}$ ,<br>$V_{GS} = 0\text{ to }-10\text{ V}$ , $R_G = 50\text{ }\Omega$<br>Duty $\leq 1\%$ , $V_{IN}$ : $t_r$ , $t_f < 5\text{ ns}$ ,<br>Common source,<br>See Chapter 5.3. | —   | 4.3  | —   | ns   |
| Switching time (turn-off time) | $t_{off}$ |                                                                                                                                                                                                                         | —   | 31.7 | —   |      |

### 5.3. Switching Time Test Circuit

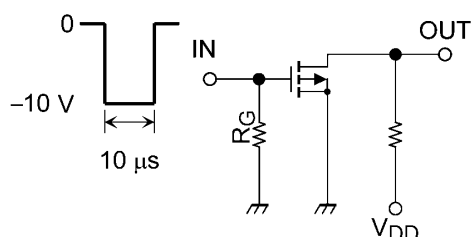


Fig. 5.3.1 Switching Time Test Circuit

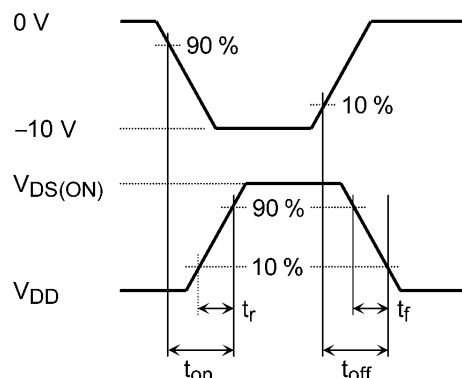


Fig. 5.3.2 Input Waveform/Output Waveform

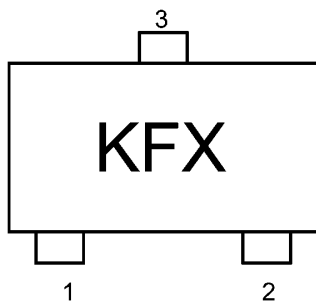
### 5.4. Gate Charge Characteristics (Unless otherwise specified, $T_a = 25\text{ }^{\circ}\text{C}$ )

| Characteristics                                 | Symbol    | Test Condition                                                               | Min | Typ. | Max | Unit |
|-------------------------------------------------|-----------|------------------------------------------------------------------------------|-----|------|-----|------|
| Total gate charge (gate-source plus gate-drain) | $Q_g$     | $V_{DD} = -48\text{ V}$ , $I_D = -0.4\text{ A}$ ,<br>$V_{GS} = -10\text{ V}$ | —   | 3.0  | —   | nC   |
| Gate-source charge 1                            | $Q_{gs1}$ |                                                                              | —   | 0.4  | —   |      |
| Gate-drain charge                               | $Q_{gd}$  |                                                                              | —   | 1.1  | —   |      |

**5.5. Source-Drain Characteristics (Unless otherwise specified,  $T_a = 25\text{ }^{\circ}\text{C}$ )**

| Characteristics                | Symbol    | Test Condition                                | Min | Typ. | Max | Unit |
|--------------------------------|-----------|-----------------------------------------------|-----|------|-----|------|
| Diode forward voltage (Note 1) | $V_{DSF}$ | $I_D = 400\text{ mA}$ , $V_{GS} = 0\text{ V}$ | —   | 0.87 | 1.2 | V    |

Note 1: Pulse measurement.

**6. Marking**

# 7. Characteristics Curves (Note)

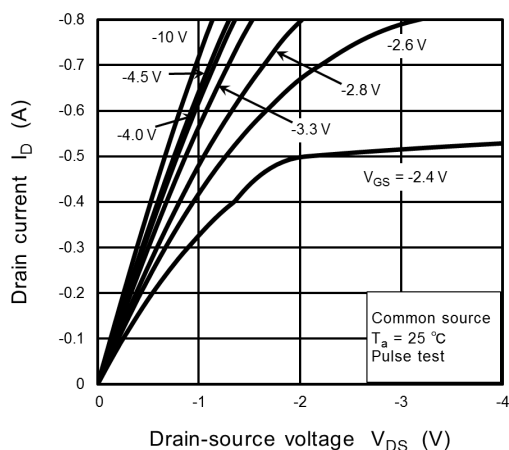


Fig. 7.1  $I_D - V_{DS}$

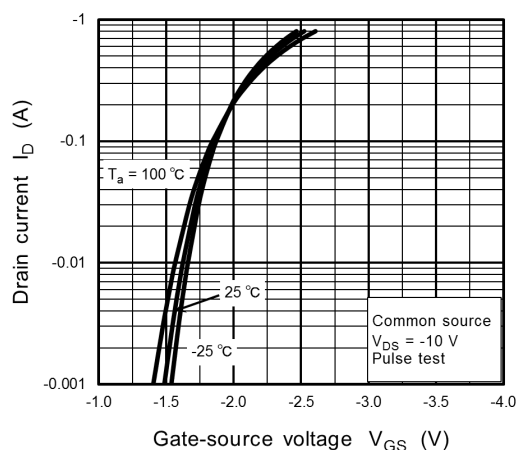


Fig. 7.2  $I_D - V_{GS}$

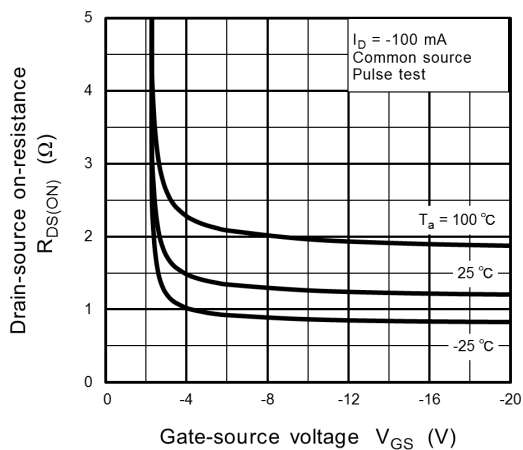


Fig. 7.3  $R_{DS(ON)} - V_{GS}$

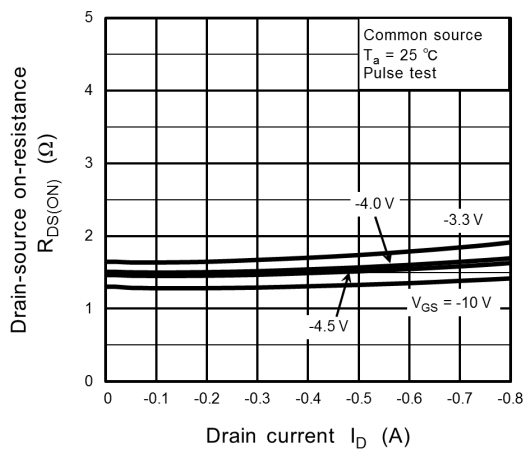


Fig. 7.4  $R_{DS(ON)} - I_D$

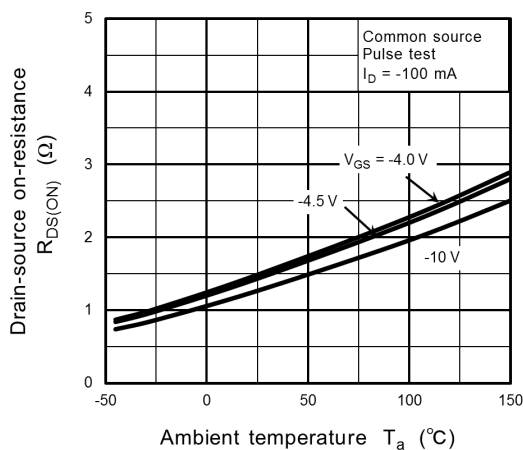


Fig. 7.5  $R_{DS(ON)} - T_a$

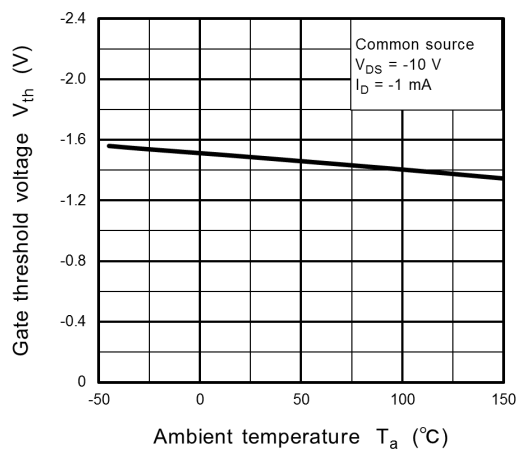
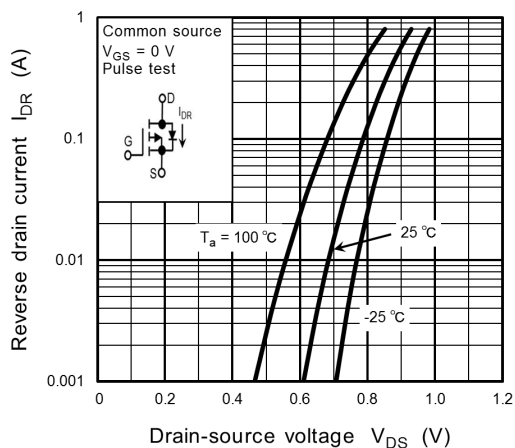
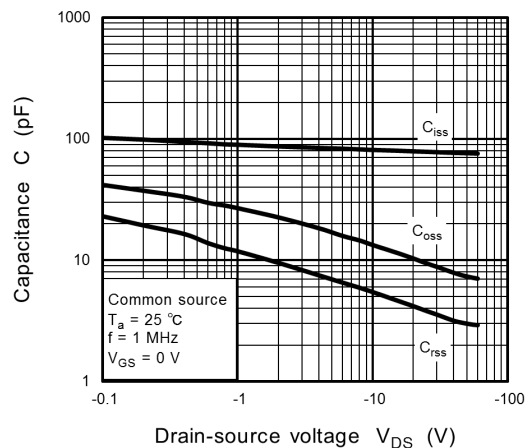


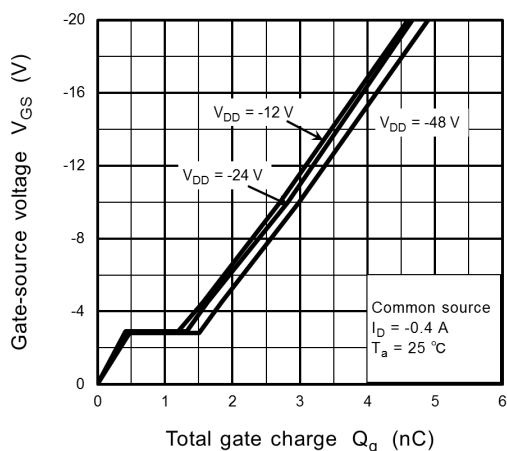
Fig. 7.6  $V_{th} - T_a$



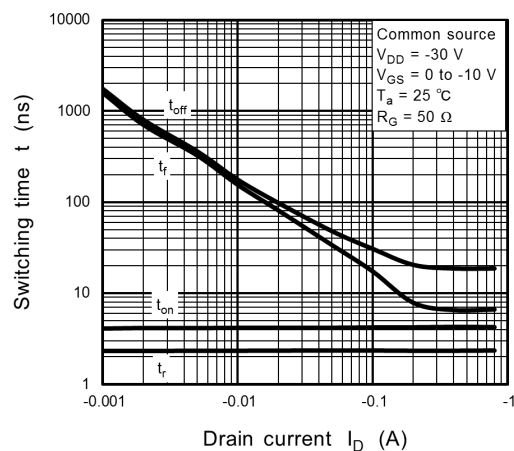
**Fig. 7.7  $I_{DR} - V_{DS}$**



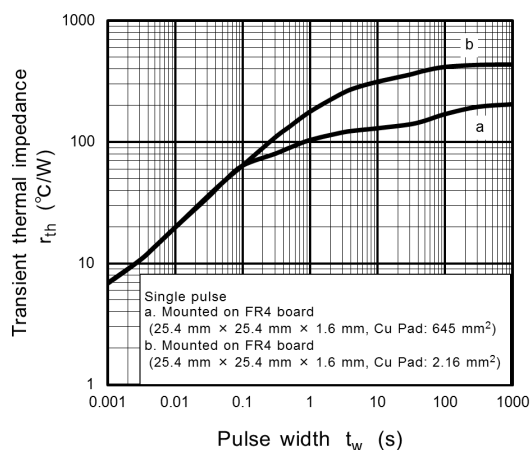
**Fig. 7.8  $C - V_{DS}$**



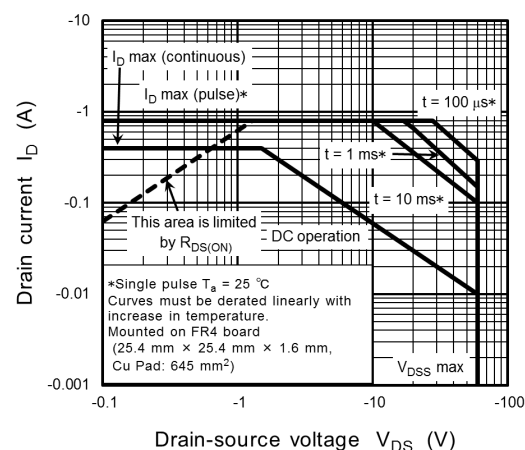
**Fig. 7.9 Dynamic Input Characteristics**



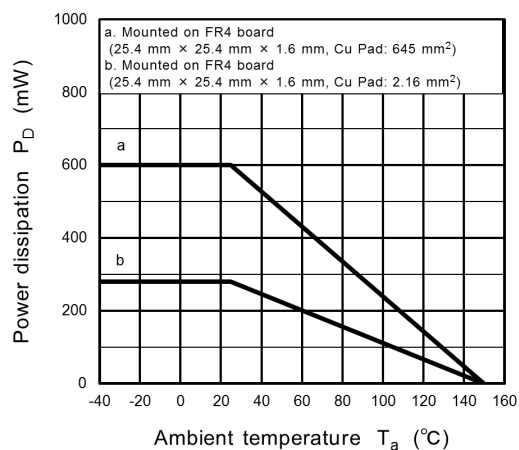
**Fig. 7.10  $t - I_D$**



**Fig. 7.11  $r_{th} - t_w$**



**Fig. 7.12 Safe Operating Area**

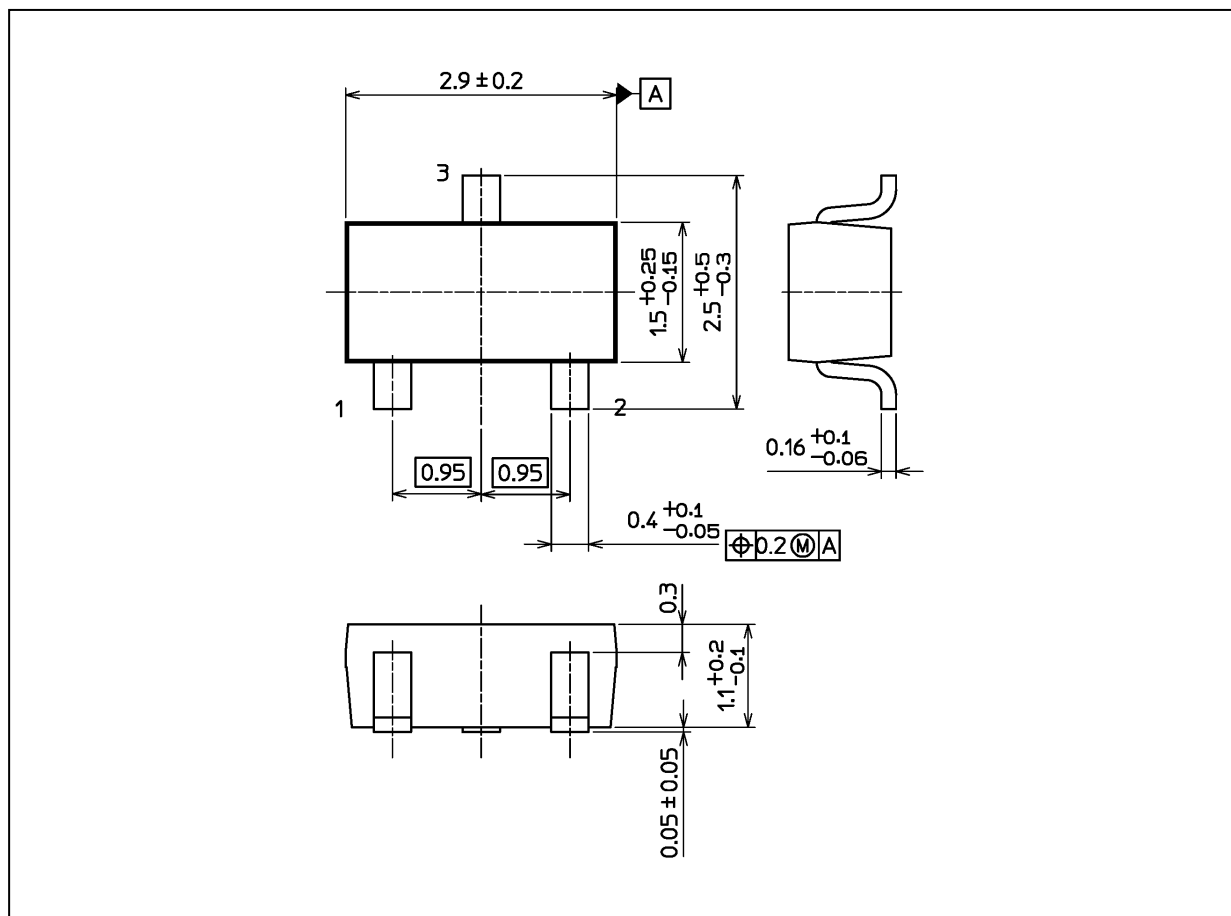


**Fig. 7.13  $P_D - T_a$**

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

## Package Dimensions

Unit: mm



Weight: 12 mg (typ.)

| Package Name(s)  |
|------------------|
| JEDEC: SOT-346   |
| Nickname: S-Mini |

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